

Search Notes

Application/Control No.

10/519,923

Examiner

James D. Ewart

Applicant(s)/Patent under
Reexamination

KROTH ET AL.

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
455	449	10/6/2006	JDE
	452.2		
	453		
	507		
370	229		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR